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(IEC 60384-9 : 2005)

(JEITA)

**Fixed capacitors for use in
electronic equipment—
Part 9: Sectional specification:
Fixed capacitors of ceramic
dielectric, Class 2**

ICS 31.060.20

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Foreword

This translation has been made based on the original Japanese Industrial Standard revised by the Minister of Economy, Trade and Industry through deliberations at the Japanese Industrial Standards Committee as the result of proposal for revision of Japanese Industrial Standard submitted by Japan Electronics and Information Technology Industries Association (JEITA) with the draft being attached, based on the provision of Article 12 Clause 1 of the Industrial Standardization Law applicable to the case of revision by the provision of Article 14.

Consequently **JIS C 5101-9:1998** is replaced with this Standard.

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JIS C 5101 consists of the following 43 parts under the general title “*Fixed capacitors for use in electronic equipment*”:

JIS C 5101-1 *Part 1: Generic specification*

JIS C 5101-2 *Part 2: Sectional specification: Fixed metallized polyethylene-terephthalate film dielectric d.c. capacitors*

JIS C 5101-2-1 *Part 2: Blank detail specification: Fixed metallized polyethylene-terephthalate film dielectric d.c. capacitors Assessment level E*

JIS C 5101-3 *Part 3: Sectional specification: Fixed tantalum chip capacitors*

JIS C 5101-3-1 *Part 3: Blank detail specification: Fixed tantalum chip capacitors Assessment level E*

JIS C 5101-4 *Part 4: Sectional specification: Aluminium electrolytic capacitors with solid and non-solid electrolyte*

JIS C 5101-4-1 *Part 4: Blank detail specification: Aluminium electrolytic capacitors with non-solid electrolyte Assessment level E*

JIS C 5101-4-2 *Part 4: Blank detail specification: Aluminium electrolytic capacitors with solid electrolyte Assessment level E*

JIS C 5101-8 *Part 8: Sectional specification: Fixed capacitors of ceramic dielectric, Class 1*

JIS C 5101-8-1 *Part 8-1: Blank detail specification: Fixed capacitors of ceramic dielectric, Class 1 Assessment level EZ*

JIS C 5101-9 *Part 9: Sectional specification: Fixed capacitors of ceramic dielectric, Class 2*

JIS C 5101-9-1 *Part 9-1: Blank detail specification: Fixed capacitors of ceramic dielectric, Class 2 Assessment level EZ*

- JIS C 5101-11 *Part 11: Sectional specification: Fixed polyethylene-terephthalate film dielectric metal foil d.c. capacitors*
- JIS C 5101-11-1 *Part 11: Blank detail specification: Fixed polyethylene-terephthalate film dielectric metal foil d.c. capacitors Assessment level E*
- JIS C 5101-13 *Part 13: Sectional specification: Fixed polypropylene film dielectric metal foil d.c. capacitors*
- JIS C 5101-13-1 *Part 13: Blank detail specification: Fixed polypropylene film dielectric metal foil d.c. capacitors Assessment level E*
- JIS C 5101-14 *Part 14: Sectional specification: Fixed capacitors for electromagnetic interference suppression and connection to the supply mains*
- JIS C 5101-14-1 *Part 14-1: Blank detail specification: Fixed capacitors for electromagnetic interference suppression and connection to the supply mains—Assessment level D*
- JIS C 5101-14-2 *Part 14-2: Blank detail specification: Fixed capacitors for electromagnetic interference suppression and connection to the supply mains—Safety tests only*
- JIS C 5101-14-3 *Part 14-3: Blank detail specification: Fixed capacitors for electromagnetic interference suppression and connection to the supply mains—Assessment level DZ*
- JIS C 5101-15 *Part 15: Sectional specification: Fixed tantalum capacitors with non-solid or solid electrolyte*
- JIS C 5101-15-1 *Part 15: Blank detail specification: Fixed tantalum capacitors with non-solid electrolyte and foil electrode Assessment level E*
- JIS C 5101-15-2 *Part 15: Blank detail specification: Fixed tantalum capacitors with non-solid electrolyte and porous anode Assessment level E*
- JIS C 5101-15-3 *Part 15: Blank detail specification: Fixed tantalum capacitors with solid electrolyte and porous anode Assessment level E*
- JIS C 5101-16 *Part 16: Sectional specification: Fixed metallized polypropylene film dielectric d.c. capacitors*
- JIS C 5101-16-1 *Part 16: Blank detail specification: Fixed metallized polypropylene film dielectric d.c. capacitors Assessment level E*
- JIS C 5101-17 *Part 17: Sectional specification: Fixed metallized polypropylene film dielectric a.c. and pulse capacitors*
- JIS C 5101-17-1 *Part 17: Blank detail specification: Fixed metallized polypropylene film dielectric a.c. and pulse capacitors Assessment level E*
- JIS C 5101-18 *Part 18: Sectional specification: Fixed aluminium electrolytic chip capacitors with solid (MnO₂) and non-solid electrolyte*
- JIS C 5101-18-1 *Part 18: Blank detail specification: Fixed aluminium electrolytic chip capacitors with solid (MnO₂) electrolyte Assessment level E*
- JIS C 5101-18-2 *Part 18: Blank detail specification: Fixed aluminium electrolytic chip capacitors with non-solid electrolyte Assessment level E*

- JIS C 5101-20 *Part 20: Sectional specification: Fixed metallized polyphenylene sulfide film dielectric chip d.c. capacitors*
- JIS C 5101-20-1 *Part 20: Blank detail specification: Fixed metallized polyphenylene sulfide film dielectric chip d.c. capacitors Assessment level EZ*
- JIS C 5101-21 *Part 21: Sectional specification: Fixed surface mount multilayer capacitors of ceramic dielectric, Class 1*
- JIS C 5101-21-1 *Part 21-1: Blank detail specification: Fixed surface mount multilayer capacitors of ceramic dielectric, Class 1—Assessment level EZ*
- JIS C 5101-22 *Part 22: Sectional specification: Fixed surface mount multilayer capacitors of ceramic dielectric, Class 2*
- JIS C 5101-22-1 *Part 22-1: Blank detail specification: Fixed surface mount multilayer capacitors of ceramic dielectric, Class 2—Assessment level EZ*
- JIS C 5101-23 *Part 23: Sectional specification—Fixed surface mount metallized polyethylene naphthalate film dielectric DC capacitors*
- JIS C 5101-23-1 *Part 23-1: Blank detail specification—Fixed surface mount metallized polyethylene naphthalate film dielectric DC capacitors—Assessment level EZ*
- JIS C 5101-24 *Part 24: Sectional specification—Surface mount fixed tantalum electrolytic capacitors with conductive polymer solid electrolyte (to be published)*
- JIS C 5101-24-1 *Part 24-1: Blank detail specification—Surface mount fixed tantalum electrolytic capacitors with conductive polymer solid electrolyte—Assessment level EZ (to be published)*
- JIS C 5101-25 *Part 25: Sectional specification—Surface mount fixed aluminium electrolytic capacitors with conductive polymer solid electrolyte (to be published)*
- JIS C 5101-25-1 *Part 25-1: Blank detail specification—Surface mount fixed aluminium electrolytic capacitors with conductive polymer solid electrolyte—Assessment level EZ (to be published)*

**Fixed capacitors for use
in electronic equipment—
Part 9: Sectional specification:
Fixed capacitors of ceramic dielectric,
Class 2**

Introduction

This Japanese Industrial Standard has been prepared based on the third edition of **IEC 60384-9** published in 2005 without modifying the technical contents.

The portions underlined with dots are the matters not stated in the original International Standard.

1 General

1.1 Scope

This Standard is a sectional specification associated with the generic specification, **JIS C 5101-1** and specifies fixed capacitors of ceramic dielectric for use in electronic equipment, Class 2. This Standard is applicable to fixed capacitors (hereafter referred to as “capacitors”) of ceramic dielectric with a defined temperature coefficient (dielectric Class 2), intended for use in electronic equipment, including leadless capacitors but excluding fixed surface mount multilayer capacitors of ceramic dielectric.¹⁾

Capacitors for electromagnetic interference suppression are not included, but are covered by **JIS C 5101-14**.

NOTE 1 This Standard specifies the characteristics of capacitors; however, specifications concerning characteristics thereof essentially show the targeted values of design, therefore it is not intended to perform conformity assessment.

NOTE 2 The leadless capacitors means capacitors of such shape as “round, without enclosure, without lead termination and opposed electrodes”, or “round metallic case, lug termination one end earthed and with mounting structure” and the like. However, “cylindrical chip” is excluded.

NOTE 3 The International Standard corresponding to this Standard is as follows.
*IEC 60384-9:2005 Fixed capacitors for use in electronic equipment—
Part 9: Sectional specification: Fixed capacitors of ceramic dielectric,
Class 2 (IDT)*

In addition, symbols which denote the degree of correspondence in the contents between the relevant International Standard and **JIS** are IDT (identical), MOD (modified), and NEQ (not equivalent) according to **ISO/IEC Guide 21**.

Note ¹⁾ For fixed surface mount multilayer capacitors of ceramic dielectric, Class 2, **JIS C 5101-22** is applicable.

1.2 Object

The object of this Standard is to prescribe preferred ratings and characteristics and to select from **JIS C 5101-1**, the appropriate quality assessment procedures, tests and measuring methods and to give general performance requirements for this type of capacitor. Test severities and requirements prescribed in detail specifications referring to this sectional specification shall be of equal or higher performance level because lower performance levels are not permitted.

1.3 Normative references

The following standards contain provisions which, through reference in this text, constitute provisions of this Standard. If the indication of the year of publication is given to these referred standards, only the edition of indicated year constitutes the provision of this Standard but the revision and amendment made thereafter do not apply. The normative references without the indication of the year of publication apply only to the most recent editions (including amendments).

JIS C 5063:1997 *Preferred number series for resistors and capacitors*

NOTE : Corresponding International Standard: IEC 60063:1963 *Preferred number series for resistors and capacitors*, Amendment 1:1967, and Amendment 2:1977 (IDT)

JIS C 5101-1:1998 *Fixed capacitors for use in electronic equipment Part 1: Generic specification*

NOTE : Corresponding International Standard: IEC 60384-1:1982 *Fixed capacitors for use in electronic equipment Part 1: Generic specification*, Amendment 2:1987, Amendment 3:1989 and Amendment 4:1992 (MOD)

In addition, **JIS C 5101-1:1998** does not correspond to the latest edition, **IEC 60384-1:1999**, so the numbering system of applicable items may not correspond with each other. In the case of deviating the numbering, the number of **IEC 60384-1:1999** is shown in NOTE.

JIS C 60068-1:1993 *Environmental testing Part 1: General and guidance*

NOTE : Corresponding International Standard: IEC 60068-1:1988 *Environmental testing Part 1: General and guidance* and Amendment 1:1992 (IDT)

JIS Z 8601:1954 *Preferred numbers*

NOTE : Corresponding International Standard: ISO 3:1973 *Preferred numbers—Series of preferred numbers* (MOD)

JIS Z 9015-1 *Sampling procedures for inspection by attributes—Part 1: Sampling schemes indexed by acceptance quality limit (AQL) for lot-by-lot inspection*

NOTE : Corresponding International Standard: IEC 60410:1973 *Sampling plans and procedures for inspection by attributes* (MOD)

1.4 Information to be given in a detail specification

Detail specifications shall be derived from the relevant blank detail specification.

Detail specifications shall not specify requirements inferior to those of the generic, sectional or blank detail specification. When more severe requirements are included,

they shall be listed in **1.9** of the detail specification and indicated in the test schedules, for example by an asterisk (*).

NOTE : The information given in **1.4.1** may for convenience, be presented in tabular form.

The following information shall be given in each detail specification and the values quoted shall preferably be selected from those given in the appropriate clause of this sectional specification.

1.4.1 Outline drawing and dimensions

There shall be an illustration of the capacitor as an aid to easy recognition and for comparison of the capacitor with others.

Dimensions and their associated tolerances, which affect interchangeability and mounting, shall be given in the detail specification. All dimensions shall preferably be stated in millimetres.

Normally, the numerical values shall be given for the length of the body, the width and height of the body and the wire spacing, or for cylindrical types, the body diameter, and the length and diameter of the terminations. When necessary, for example when a number of items (capacitance values/voltage ranges) are covered by a detail specification, the dimensions and their associated tolerances shall be placed in a table below the drawing.

When the configuration is other than described above, the detail specification shall state such dimensional information as will adequately describe the capacitors. When the capacitor is not designed for use on printed boards, this shall be clearly stated in the detail specification.

1.4.2 Mounting

The detail specification shall specify the method of mounting to be applied for normal use and for the application of the vibration and the bump or shock tests. The capacitors shall be mounted by their normal means. The design of the capacitor may be such that special mounting fixtures are required in its use. In this case, the detail specification shall describe the mounting fixtures and they shall be used in the application of the vibration and bump or shock tests.

1.4.3 Ratings and characteristics

The ratings and characteristics shall be in accordance with the relevant clauses of this specification, together with the following:

1.4.3.1 Rated capacitance range

See **2.2.4.1**.

NOTE : In the case of International Electrotechnical Commission Quality Assessment System for Electronic Components (**IECQ**), when products approved to the detail specification have different ranges, the following statement should be added: "The range of values available in each voltage range is given in the qualified product list (**QPL**)."

1.4.3.2 Particular characteristics

Additional characteristics may be listed, when they are considered necessary to specify adequately the component for design and application purposes.

1.4.3.3 Soldering

The detail specification shall prescribe the test methods, severities and requirements applicable for the solderability and the resistance to soldering heat tests.

1.4.4 Marking

The detail specification shall specify the content of the marking on the capacitor and on the package. Deviations from **1.6** of this sectional specification, shall be specifically stated.

1.5 Terms and definitions

For the purposes of this Standard, the applicable terms and definitions of **JIS C 5101-1** and the following apply.

1.5.1 fixed capacitors of ceramic dielectric, Class 2

capacitor which has a dielectric with a high permittivity and is suitable for by-pass and coupling applications or for frequency discriminating circuits where low losses and high stability of capacitance are not of major importance

The ceramic dielectric is characterized by the non-linear change of capacitance over the category temperature range (see table 2).

1.5.2 subclass

maximum percentage change of capacitance within the category temperature range with respect to the capacitance at 20 °C

NOTE : The subclass may be expressed in code form (see table 2).

1.5.3 rated voltage (U_R)

maximum d.c. voltage which may be applied continuously to the terminations of a capacitor at the rated temperature

NOTE : The sum of the d.c. voltage and the peak a.c. voltage applied to the capacitor should not exceed the rated voltage. The value of the peak alternating voltage should not exceed the value determined by the permissible reactive power.

1.6 Marking

See **JIS C 5101-1, 2.4** with the following details:

1.6.1 Marking on the capacitor and the package

The information given in the marking is normally selected from the following list; the relative importance of each item is indicated by its position in the list:

- a) rated capacitance;
- b) rated voltage (d.c. voltage may be indicated by the symbol --- or —);
- c) tolerance on rated capacitance;

- d) the dielectric subclass, see table 2;
- e) year and month (or week) of manufacture;
- f) manufacturer's name or trade mark;
- g) climatic category;
- h) manufacturer's type designation;
- i) reference to the detail specification.

NOTE : Information required under **1.6.1 b)** and **1.6.1 d)** may be given in code form under manufacturer's, or national, type or style designation.

1.6.2 Marking on the capacitor

The capacitor shall be clearly marked with **a)**, **b)** and **c)** above and with as many as possible of the remaining items as is considered necessary. Any duplication of information in the marking on the capacitor should be avoided

1.6.3 Marking on the package

The package containing the capacitor(s) shall be clearly marked with all the information listed in **1.6.1**.

1.6.4 Additional marking

Any additional marking other than those specified in **1.6.1** shall be so applied that no confusion can arise.

2 Preferred ratings and characteristics

2.1 Preferred characteristics

The values given in detail specifications shall preferably be selected from the following:

2.1.1 Preferred climatic categories

The capacitors covered by this specification are classified into climatic categories according to the general rules given in clause **8** of **JIS C 60068-1**.

The lower and upper category temperatures and the duration of the damp heat, steady state test shall be chosen from the following:

Lower category temperature: -55 °C, -40 °C, -25 °C and -10 °C

Upper category temperature: +70 °C, +85 °C, +100 °C and +125 °C

Duration of the damp heat, steady state test: 4, 10, 21 and 56 days

The severities for the cold and dry heat tests are the lower and upper category temperatures respectively.

2.2 Preferred values of ratings

2.2.1 Rated temperature

For capacitors covered by this specification, the rated temperature is equal to the upper category temperature.